

Product Summary

V _{(BR)DS} S	RDS(ON) Max	Package	Ι _D T _A = +25°C
-30V	$25m\Omega @V_{GS} = -10V$	SO-8	-6.0 A
-307	$38m\Omega @V_{GS} = -4.5V$	30-0	-4.7A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Load Switch

Features

- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)

30V DUAL P-CHANNEL ENHANCEMENT MODE MOSFET

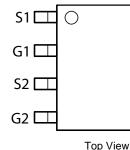
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

Mechanical Data

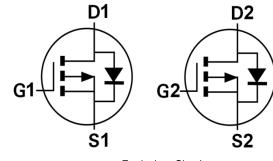
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208 ⁽³⁾
- Weight: 0.074 grams (approximate)



Top View







Equivalent Circuit

Ordering Information (Note 4)

Case	Packaging
SO-8	2,500/Tape & Reel
-	Case

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

 See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

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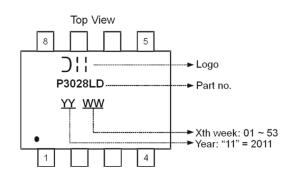
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 $\Box D2$

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html

Marking Information





Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage		V _{DSS}	-30	V	
Gate-Source Voltage		V _{GSS}	±20	V	
	Steady State	T _A = +25°C T _A = +70°C	ID	-6 -4.7	A
Continuous Drain Current (Note 5) V _{GS} = 10V	t<10s	T _A = +25°C T _A = +70°C	ID	-7.4 -5.8	А
Maximum Body Diode Forward Current (Note 6)	ls	-2.5	А		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I _{DM}	-30	А

Thermal Characteristics

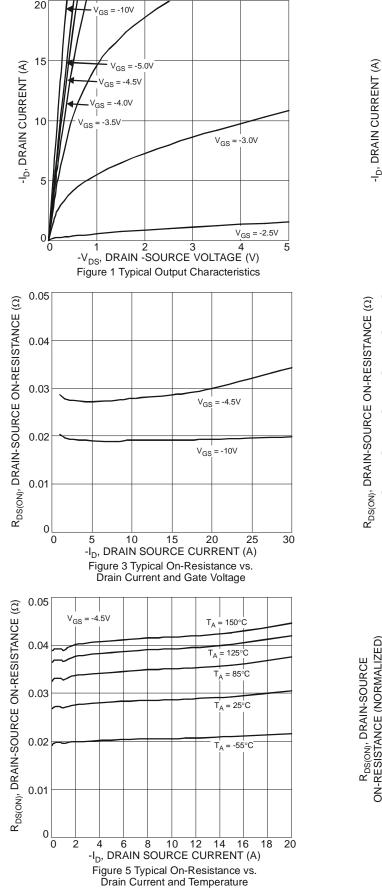
Characteristic		Symbol	Value	Units
Total Dawar Dissinction (Nata 5)	T _A = +25°C	D	1.3	W
Total Power Dissipation (Note 5)	$T_A = +70^{\circ}C$	PD	0.8	
Thermal Desistance, Junction to Ambient (Note 5)	Steady state	D.	102	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	R _{0JA}	61	
Total Bower Dissinction (Note 6)	$T_A = +25^{\circ}C$	D	1.7	W
Total Power Dissipation (Note 6)	T _A = +70°C	PD	1.1	
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	D.	75	°C/W
mermai Resistance, Junction to Ambient (Note 6)	t<10s	Røja	50	
Thermal Resistance, Junction to Case (Note 6)	Rejc	14.5		
Operating and Storage Temperature Range		TJ. TSTG	-55 to +150	°C

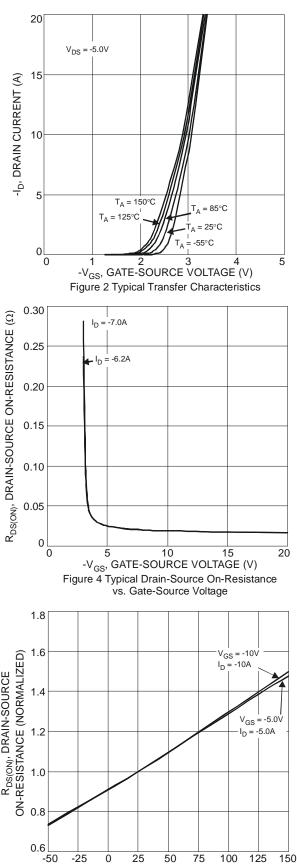
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	-30	_	—	V	$V_{GS} = 0V, I_D = -250 \mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	—	-	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	—	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(th)}	-1	—	-3	V	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	
Static Drain-Source On-Resistance	Proven	—	20	25	mΩ	$V_{GS} = -10V, I_D = -7A$	
Static Drain-Source On-resistance	R _{DS(ON)}	—	29	38	1115.2	$V_{GS} = -4.5V, I_D = -5.5A$	
Forward Transfer Admittance	Y _{fs}	_	11	—	S	$V_{DS} = -5V, I_D = -7A$	
Diode Forward Voltage	V _{SD}	—	0.7	1.2	V	$V_{GS} = 0V, I_{S} = -2.1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss	—	1241	—		V _{DS} = -15V, V _{GS} = 0V f = 1.0MHz	
Output Capacitance	C _{oss}	—	147	—	pF		
Reverse Transfer Capacitance	Crss	—	110	—		1 = 1.000112	
Gate Resistance	R _G	—	15	—	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V _{GS} = -4.5V)	Qg	—	22	—			
Total Gate Charge (V _{GS} = -10V)	Qg	—	10.9	—	nC	V _{DS} = -15V, I _D = -7A	
Gate-Source Charge	Q _{gs}	_	3.5	—	nc		
Gate-Drain Charge	Q _{gd}	_	4.7	—			
Turn-On Delay Time	t _{D(on)}	_	9.7	_		V _{GS} = -10V, V _{DD} = -15V, R _{GEN} = 6Ω,	
Turn-On Rise Time	tr	_	17.1	—	nS		
Turn-Off Delay Time	t _{D(off)}	—	60.5	_	113	I _D = -7A	
Turn-Off Fall Time	t _f		40.4]		

 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing. Notes:

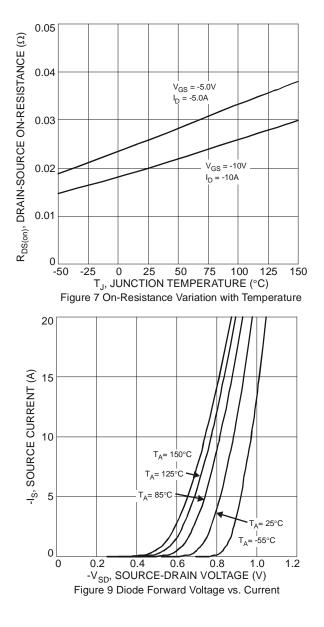


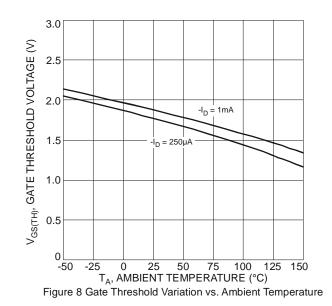




T_J, JUNCTION TEMPERATURE (°C) Figure 6 On-Resistance Variation with Temperature



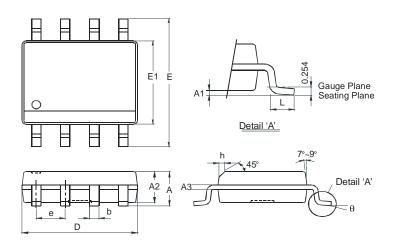






Package Outline Dimensions

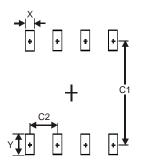
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SO-8					
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
E	5.90	6.10				
E1	3.85	3.95				
е	1.27 Typ					
h	-	0.35				
L	0.62	0.82				
Θ	0°	8°				
All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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